Supporting Information

High-Performance Layered Potassium Vanadium Oxide for K-Ion Batteries

Enabled by Reduced Long-Range Structural Order

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Fig. S1. The high-resolution V2p XPS spectra of a) KVO-H and b) KVO.



Fig. S2. XRD patterns of the as-prepared KVO-H and the samples annealed at 250, 300, 400, and 500 $^{\circ}$ C, respectively. The standard XRD pattern of monoclinic K_{0.486}V₂O₅ (JCPDF No. 86-0347) is also presented.



Fig. S3. The DSC profile of KVO-H.



Fig. S4. SEM image of KVO-H.



Fig. S5. a) SEM, b) TEM, and c) HRTEM images of KVO. d) Lattice spacing of the (001) plane for KVO measured from the HRTEM image shown in (c).



Fig. S6. N_2 adsorption–desorption isotherms and the Brunauer–Emmett–Teller (BET) surface areas of a) KVO-H and b) KVO. Barrett–Joyner–Halenda (BJH) pore areas of (c) KVO-H and (d) KVO.



Fig. S7. Charge–discharge curves of KVO-H and the samples annealed at 250, 300, 400, and 500 $^{\circ}$ C, respectively. The specific current 20 mA g⁻¹ was used for all the tests.



Fig. S8. Electrochemical performance of the full cell. a) Charge–discharge curves of KVO-H and commercial graphite at 20 mA g^{-1} . b) Charge–discharge curves of the full cell at 20 and 100 mA g^{-1} . c) Cycling performance of the full cell at 100 mA g^{-1} with the initial 11 cycles tested at 20 mA g^{-1} .



Fig. S9. *Ex-situ* XRD results of (a) the KVO electrode and (b) the KVO-H electrode before and after 50 cycles. The baselines of all XRD results are fixed corresponding to the diffraction signals of the Al current collector at 2θ of 65.1° and 78.2°, which are marked with asterisk.



Fig. S10. *Ex-situ* TEM characterization of a, b) KVO and c, d) KVO-H after 1 cycle and 10 cycles, respectively. The insets are the corresponding SAED patterns. The fractures in Fig. S10a are marked by the red dashed squares.



Fig. S11. Characterization of the amorphous $K_{0.5}V_2O_5$. a) XRD pattern, b) HRTEM image and the corresponding SAED image, c) CV profile performed at 0.1 mV s⁻¹, d) charge–discharge curves at the specific current of 20 mA g⁻¹.



Fig. S12. *Ex-situ* SEM characterization of the KVO electrode: a) before charge-discharge, b) after 1 charge-discharge cycle, and c) after 50 charge-discharge cycles, respectively; *Ex-situ* SEM characterization of the KVO-H electrode: c) before charge-discharge, d) after 1 charge-discharge cycle, and e) after 50 charge-discharge cycles, respectively.



Fig. S13. Nyquist plots of a) the KVO and b) KVO-H electrodes after cycling. All EIS tests were performed at the fully charged state (4.5 V *vs.* K^+/K).



Fig. S14. CV profiles of a) the KVO and b) KVO-H electrodes at different scan rates. The dashed lines in the plots are used as a guide for eyes to show the variations of the current peaks with scan rates.



Fig. S15. a) V K-edge XANES spectra for KVO at the fully charged and discharged states. b) The enlarged areas marked by the red dashed square in (a).



Fig. S16. a) Quasi-equilibrium potential and transient potential profiles *vs.* specific capacity for K-ions intercalation/deintercalation in the KVO obtained from GITT. b) Reaction resistance for K-ions intercalation into the KVO. c) Reaction resistance for K-ion deintercalation from the KVO. d) The calculated apparent chemical diffusion coefficient of potassium (D_K) in the KVO *vs.* specific capacity.



Fig. S17. Structures of a) δ -V₂O₅·H₂O, b) δ ₁-V₂O₅, and c) δ ₁-V₂O₅·0.5H₂O.



Fig. S18. Structures of a) $\delta\text{-}K_{0.5}V_2O_5,$ b) $\delta_2\text{-}V_2O_5,$ and c) $\delta_2\text{-}V_2O_5\text{-}0.5H_2O.$



Fig. S19. Structures of a) δ_2 -V₂O₅·0.5H₂O, b) δ_2 -K_{0.25}V₂O₅·0.5H₂O, c) δ_2 -K_{0.50}V₂O₅·0.5H₂O, d) δ_2 -K_{0.75}V₂O₅·0.5H₂O, and e) δ_2 -K_{1.00}V₂O₅·0.5H₂O.



Fig. S20. Comparison of the XRD result of the KVO electrode at the fully charged state after the first charge process with the expected diffraction response of δ_1 -V₂O₅ and δ_2 -V₂O₅ obtained from the DFT calculations. The diffraction signals of Al current collector are also marked in the plot.



Fig. S21. Structures of a) δ_1 -V₂O₅, b) δ_1 -K_{0.25}V₂O₅, c) δ_1 -K_{0.50}V₂O₅, d) δ_1 -K_{0.75}V₂O₅, and e) δ_1 -K_{1.00}V₂O₅.



Fig. S22. Structures of a) δ_2 -V₂O₅, b) δ_2 -K_{0.25}V₂O₅, c) δ_2 -K_{0.50}V₂O₅, d) δ_2 -K_{0.75}V₂O₅, and e) δ_2 -K_{1.00}V₂O₅.



Fig. S23. The calculated (a and b) lattice parameters and (c) unit cell volumes of δ_1 -K_xV₂O₅ (0 $\leq x \leq 1$) at various K-ion contents. (d) The difference of the unit cell volume between δ_1 -K_xV₂O₅ (0 $\leq x \leq 1$) and δ_1 -V₂O₅.



Fig. S24. The calculated (a and b) lattice parameters and (c) unit cell volumes of δ_2 -K_xV₂O₅ (0 $\leq x \leq 1$) at various K-ion contents. (d) The difference of the unit cell volume between δ_2 -K_xV₂O₅ (0 $\leq x \leq 1$) and δ_2 -V₂O₅.



Fig. S25. The unit cell volume difference between δ_1 -K_xV₂O₅ and δ_2 -K_xV₂O₅ ($0 \le x \le 1$) in comparison with the unit cell volume of δ_2 -K_xV₂O₅ ($0 \le x \le 1$).